

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/026,091	FORREST ET AL.	
Examiner	Art Unit	
Mario P. Vamnitzky	1774	

	SEAR	CHED	
Class	Subclass	Date	Examiner
250	200, 215	6/2/2005	MRY
136 I	243, 252		
	263		
257	184, 431		
	449, 461		
	464		
-313	523, 540		
428 I	411.1		
	458, 469		
	913, 212	1	→
257 ——— L	E51.017	2/1/2006	MRY
	E31.003		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
see "SRFW (01/05/20005)" in eDAN file.	6/2/2005	MRY
USPTO STIC Translation Branch - Akiko Smith - partial oral translation of JP 63-300576.	6/2/2005	MRY
EAST - see search history printout - US-PGPUB; USPAT: text search; limited classified search of 250/200,215; 136/243,252,263;	2/1/2006	MRY
257/184,431,449,461,464; 313/523,540; 428/212,411.1,458,469,913; full search of 257/E51.017,E31.003.	2/1/2006	MRY